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Form PTO 1449
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PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
217075US2PCTSERIAL NO.
10/031,570

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Joseph T. VERDEYEN, et al.

FILING DATE

January 22, 2002

GROUP

2133 1765

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W	AA	2,405,229	8-6-1946	MUELLER et al.			
	AB	2,483,189	9-27-1949	C. C. EAGLESFIELD			
	AC	2,735,941	2-21-1956	R. C. PECK			
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W	AO	0 432 573	6-19-1991	EUROPE	
	AP	WO 01/06544	1-25-2001	WIPO	
	AQ	WO 01/37306	5-25-2001	WIPO	
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W	AW	P. K. Atrey et al., "Measurement of chord averaged electron density in ADITYA using 100 GHz and 136 GHz interferometers", Indian J. Physics 66B (5 & 6), 1992, pp. 489-97.	
	AX	D. Bora et al., "Plasma density measurement using a simple microwave technique", Rev. Sci. Instrum. 59 (10), 10/1988, pp. 2149-51.	
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	AZ	Nils Brenning, "An improved microwave interferometer technique for plasma density measurements", J. Phys. E: Sci. Instrum. 21, 1988, pp. 578-82.	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

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5/27/04

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Joseph T. VERDEYEN, et al.		GROUP 2133 1765-000	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
[Signature]	AA	3,699,475	10-17-1972	R. G. ROGERS			
	AB	3,899,752	8-12-1975	H. F. ENGELMANN			
	AC	3,956,695	5-11-1976	M. E. STAMM			
	AD	4,034,312	7-5-1977	M. ARMAND			
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[Signature]	AW	N. Brenning, "An improved microwave interferometer technique for plasma density measurements", J. Phys. E: Sci. Instrum. 17, 1984, pp. 1018-23.					
	AX	M. A. G. Calderon et al., "Experimental study of a swept reflectometer with a single antenna for plasma density profile measurement", International Journal of Infrared and Millimeter Waves 6 (7), 1985, pp. 605-28.					
	AY	G. D. Conway et al., "Plasma density fluctuation measurements from coherent and incoherent microwave reflection", Plasma Phys. Control. Fusion 38, 1996, pp. 451-66.					
	AZ	P. C. Efthimion et al., "1-millimeter wave interferometer for the measurement of line integrated electron density on TFTR", Rev. Sci. Instrum. 56 (5), 05/1985, pp. 998-1007.					
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JH	AA	5,691,642	11-25-1997	D. M. DOBKIN			
	AB	6,074,568	6-13-2000	ADACHI et al.			
	AC	5,621,331	4-15-1997	SMITH et al.			
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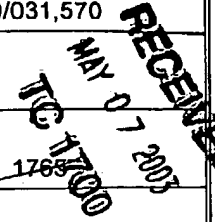
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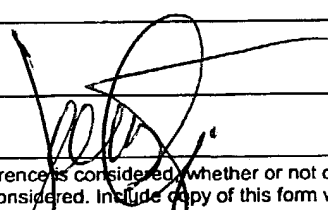
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	AAA	Thomton, "Diagnostic methods for sputtering plasmas", J. Vac. Sci. Technol. 15 (2), March/April 1978, pp. 188-92.					
	AAB	J. R. Wallington et al., "A sensitive microwave interferometer for plasma diagnostics", J. Plasma Physics 3 (part 3), 1969, pp. 371-5.					
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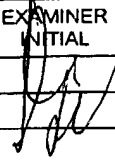
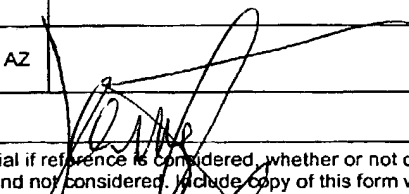
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	AAH	J. Clarke, "A simple stabilized microwave source", IEEE Transactions on Instrument and Measurement, Vol. IM-21 (1), 02/1972, pp. 83-4. INSPEC abstract number B72013995.					
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	AAQ	Sheng-Min Liu et al., "The millimeter wave Gunn oscillator and self-oscillating mixer using the nonradiative dielectric waveguide", International conference on millimeter waves and far-infrared technology conference digest (Cat. no. 89TH0257-6), 1989, pp. 450-2.					
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